

**Search Notes**

Application/Control No.

10/780,829

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

MAYER ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	545 Updated Search	3/31/2005	YMY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	3/31/2005	YMY